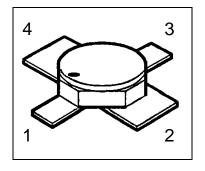


# **HiRel NPN Silicon RF Transistor**

- HiRel Discrete and Microwave Semiconductor
- For low noise, high-gain amplifiers up to 2GHz.
- For linear broadband amplifiers
- Hermetically sealed microwave package
- f<sub>T</sub>= 8 GHz
   F = 2.3 dB at 2 GHz

ESA/SCC Detail Spec. No.: 5611/006

Type Variant No. 06



**ESD**: Electrostatic discharge sensitive device, observe handling precautions!

Туре	Marking	Ordering Code	Pin Configuration			Package	
			1	2	3 4	Ļ	
BFY193 (ql)	-	see below	С	Е	В	Е	Micro-X1

(ql) Quality Level: P: Professional Quality

H: High Rel Quality

S: Space Quality

ES: ESA Space Quality

(see order instructions for ordering example)

K/W



Parameter	Symbol	Values	Unit
Collector-emitter voltage	$V_{CEO}$	12	V
Collector-emitter voltage, V <sub>BE</sub> =0	V <sub>CES</sub>	20	V
Collector-base voltage	$V_{CBO}$	20	V
Emitter-base voltage	$V_{EBO}$	2	V
Collector current	Ic	80	mA
Base current	I <sub>B</sub>	10 <sup>1)</sup>	mA
Total power dissipation, $T_S \le 104^{\circ}C^{2),3)}$	P <sub>tot</sub>	580	mW
Junction temperature	T <sub>j</sub>	200	°C
Operating temperature range	T <sub>op</sub>	-65+200	°C
Storage temperature range	T <sub>stg</sub>	-65+200	°C

 $R_{\text{th JS}}$ 

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# Junction-soldering point 3) Notes.:

## **Electrical Characteristics**

at T<sub>A</sub>=25°C; unless otherwise specified

Parameter	Symbol	Values			Unit	
		min.	typ.	max.		
DC Characteristics						
Collector-base cutoff current	I <sub>CBO</sub>	-	-	100	μA	
$V_{CB} = 20 \text{ V}, I_{E} = 0$						
Collector-emitter cutoff current	I <sub>CEX</sub>	-	-	600	μΑ	
$V_{CE} = 12 \text{ V}, I_B = 0.5 \mu A^{-1.}$						
Collector-base cutoff current	I <sub>CBO</sub>	-	-	50	nA	
$V_{CB} = 10 \text{ V}, I_{E} = 0$						
Emitter base cuttoff current	I <sub>EBO</sub>	-	-	25	μΑ	
$V_{EB} = 2 \text{ V}, I_{C} = 0$						
Emitter base cuttoff current	I <sub>EBO</sub>	-	-	0.5	μΑ	
$V_{EB} = 1 \text{ V}, I_{C} = 0$						

## Notes:

1.) This Test assures V(BR)CE0 > 12V

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<sup>1)</sup> The maximum permissible base current for V<sub>FBE</sub> measurements is 30mA (spotmeasurement duration < 1s)

<sup>2)</sup> At  $T_S = +104$  °C. For  $T_S > +104$  °C derating is required. 3)  $T_S$  is measured on the collector lead at the soldering point to the pcb.



# **Electrical Characteristics** (continued)

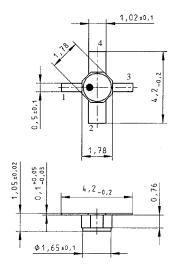
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					1
Base-Emitter forward voltage	$V_{FBE}$	-	-	1	V
$I_E = 30 \text{ mA}, I_C = 0$					
DC current gain	h <sub>FE</sub>	50	100	175	-
$I_C = 30$ mA, $V_{CE} = 8$ V					
AC Characteristics	·				
Transition frequency	f <sub>T</sub>				GHz
$I_C = 40 \text{mA}, \ V_{CE} = 5 \ \text{V}, \ f = 500 \ \text{MHz}$		6,5	7.5	-	
$I_C$ = 50 mA, $V_{CE}$ = 8 V, f = 500 MHz		-	8	-	
Collector-base capacitance	ССВ	-	0.56	0.75	pF
$V_{CB} = 10 \text{ V}, V_{BE} = \text{vbe} = 0, f = 1 \text{ MHz}$					
Collector-emitter capacitance	C <sub>CE</sub>	-	0.34	-	pF
$V_{CE} = 10 \text{ V}, V_{BE} = \text{vbe} = 0, f = 1 \text{ MHz}$					
Emitter-base capacitance	C <sub>EB</sub>	-	1.9	2.4	pF
$V_{EB} = 0.5V$ , $V_{CB} = vcb = 0$ , $f = 1 \text{ MHz}$					
Noise Figure	F	-	2.3	2.9	dB
$I_C$ = 15 mA, $V_{CE}$ = 5 V, f = 2 GHz,					
$Z_S = Z_{Sopt}$					
Power gain	Gma 1.)	12.5	13.5	-	dB
$I_C = 40$ mA, $V_{CE} = 5V$ , $f = 2$ GHz					
$Z_S = Z_{Sopt}$ , $Z_L = Z_{Lopt}$					
Transducer gain	$ S_{21e} ^2$	8	9	-	dB
$I_C = 40$ mA, $V_{CE} = 5$ V, $f = 2$ GHz					
$Z_S = Z_L = 50 \Omega$					
Output Power	P <sub>OUT</sub>	16.5	17.5	-	dBm
$I_C = 50$ mA, $V_{CE} = 5$ V, $f = 2GHz$ ,					
$P_{IN}$ =10dBm, $Z_S = Z_L = 50 \Omega$					

Notes.:

1.) 
$$G_{ma} = \left| \frac{S21}{S12} \right| (k - \sqrt{k^2 - 1}), \quad G_{ms} = \left| \frac{S21}{S12} \right|$$



## Micro-X1 Package



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